Notice of References Cited

		·	
Application/Control No.	Applicant(s)/P	atent Under	
09/970,154		Reexamination SHINKAWA ET AL.	
Examiner	Art Unit		
David A. Saunders, PhD	1644	Page 1 of 1	

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-5,429,746	07-1995	Shadle et al.	210/635
	В	US-			
	С	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	Н	US-			
	1	US-			
	J	US-			
	К	US-			
	L	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	Q					
	R					
	s					
	Т					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	Danielsson et al, Journal of Immunological Methods,115, 79-88,1988.
	٧	Goheen et al, Journal of Chromatography, 326, 235-241,1985
	W	
	х	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.